

Search Notes

Application/Control No.

10/612,615

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

INOUE ET AL.

Art Unit

2652

SEARCHED

Class	Subclass	Date	Examiner
369	283		
	286		
	288		
	275.3		
	111		
428	64.1	6/21/2005	TJ

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Reports	6/21/2005	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner